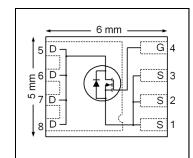


V _{DSS}	30	V
R _{DS(on) max} (@ V _{GS} =10V)	4.5	mΩ
Qg (typical)	16	nC
I _D (@T _{c(Bottom)} = 25°C)	79©	А



PQFN 5 x 6 mm

Applications

• Control MOSFET for Buck Converters

Features and Benefits

Features

Features		Benefits
Low charge (typical 16nC)		Lower Conduction Losses
Low Thermal Resistance to PCB (<2.7°C/W)		Increased Power Density
100% Rg Tested		Increased Reliability
Low Profile (≤ 0.9 mm)	results ir	Increased Power Density
Industry-Standard Pinout	\Rightarrow	Multi-Vendor Compatibility
Compatible with Existing Surface Mount Techniques		Easier Manufacturing
RoHS Compliant, Halogen-Free		Environmentally Friendlier
MSL1, Industrial Qualification		Increased Reliability

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFH5304PbF	PQFN 5 mm x 6 mm	Tape and Reel	4000	IRFH5304TRPbF

Absolute Maximum Ratings

	Parameter	Max.	Units
V _{DS}	Drain-to-Source Voltage	30	V
V _{GS}	Gate-to-Source Voltage	± 20	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	22	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	17	
I _D @ T _{c(Bottom)} = 25°C	Continuous Drain Current, V _{GS} @ 10V	796	A
$_{0} @ T_{c(Bottom)} = 100^{\circ}C$ Continuous Drain Current, V _{GS} @ 10V		506	
IDM	Pulsed Drain Current®	320	
P _D @T _A = 25°C	Power Dissipation	3.6	W
P _D @T _{c(Bottom)} = 25°C	Power Dissipation	46	
	Linear Derating Factor®	0.029	W/°C
TJ	Operating Junction and	-55 to + 150	°C
T _{STG}	Storage Temperature Range		

Notes ${\rm \textcircled{O}}$ through ${\rm \textcircled{G}}$ are on page 8

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	30			V	V _{GS} = 0V, I _D = 250µA
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	Reference to 25° C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.8	4.5	mΩ	V _{GS} = 10V, I _D = 47A ②
			5.8	6.8		V _{GS} = 4.5V, I _D = 47A ②
V _{GS(th)}	Gate Threshold Voltage	1.35	1.8	2.35	V	$V_{DS} = V_{GS}, I_D = 50 \mu A$
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-6.6		mV/°C	
I _{DSS}	Drain-to-Source Leakage Current			5.0		$V_{DS} = 24V, V_{GS} = 0V$
				150	μA	V _{DS} = 24V, V _{GS} = 0V, T _J = 125°C
I _{GSS}	Gate-to-Source Forward Leakage			100		V _{GS} = 20 V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20 V
gfs	Forward Transconductance	88			S	V _{DS} = 15 V, I _D = 47A
Q _g	Total Gate Charge		41			V _{GS} = 10V, V _{DS} = 15V, I _D = 49A
Q _g	Total Gate Charge		16	56		V _{DS} = 15V
Q_{gs1}	Pre-Vth Gate-to-Source Charge		3.6			I _D = 47A
Q_{gs2}	Post-Vth Gate-to-Source Charge		2.7		nC	V _{GS} = 4.5V
Q_gd	Gate-to-Drain Charge		5.8			See Fig.17 & 18
Q_{godr}	Gate Charge Overdrive		3.9			
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		8.5			
Q _{oss}	Output Charge		9.8		nC	V _{DS} = 16V, V _{GS} = 0V
R _G	Gate Resistance		1.2		Ω	
t _{d(on)}	Turn-On Delay Time		13			V_{DD} = 15V, V_{GS} = 4.5V
t _r	Rise Time		25		ns	I _D = 47A
t _{d(off)}	Turn-Off Delay Time		12			R _G = 1.8Ω
t _f	Fall Time		6.6			See Fig.15
C _{iss}	Input Capacitance		2360			V _{GS} = 0V
C _{oss}	Output Capacitance		510		pF	V _{DS} = 10V
C _{rss}	Reverse Transfer Capacitance		220		1	f = 1.0MHz

Avalanche Characteristics

	Parameter	Тур.	Max.	Units
E _{AS}	Single Pulse Avalanche Energy ②		46	mJ
I _{AR}	Avalanche Current①		47	A

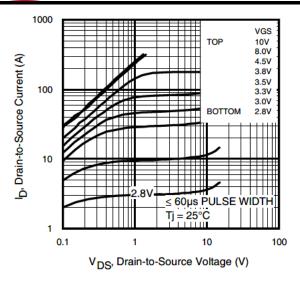
Diode Characteristics

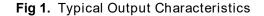
	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current			46	Α	MOSFET symbol
	(Body Diode)					showing the $(- + + + + + + + + + + + + + + + + + + $
I _{SM}	Pulsed Source Current			320①		integral reverse
	(Body Diode)					p-n junction diode.
V_{SD}	Diode Forward Voltage		0.71			T _J = 25°C, I _S =5A, V _{GS} =0V ③
V _{SD}	Diode Forward Voltage			1.0	V	T _J = 25°C, I _S =47A, V _{GS} =0V ③
t _{rr}	Reverse Recovery Time		19	29	ns	T _J = 25°C, I _F = 47A, V _{DD} = 15V
Q _{rr}	Reverse Recovery Charge		44	66	nC	di/dt = 300A/µs
t _{on}	Forward Turn-On Time	Time is dominated by parasitic Inductance				

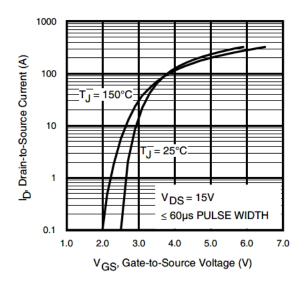
Thermal Resistance

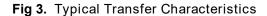
	Parameter	Тур.	Max.	Units
R _{θJC} (Bottom)	Junction-to-Mounting Base ④		2.7	
R _{θJC} (Top)	Junction-to-Case ④		15	°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient ©		35	
R _{θJA} (<10s)	Junction-to-Ambient ©		22	











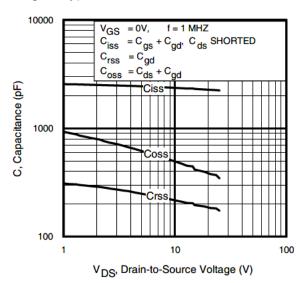


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

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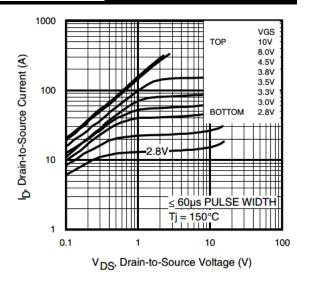


Fig 2. Typical Output Characteristics

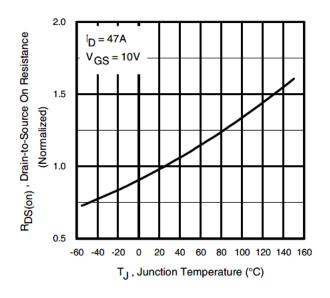


Fig 4. Normalized On-Resistance vs. Temperature

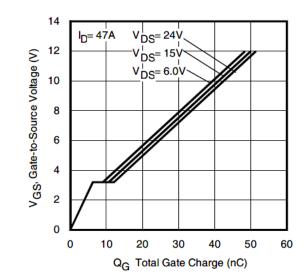


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



1000.0 I_{SD}, Reverse Drain Current (A) 100.0 Tj = 150°C 10.0 = 25°C 1.0 GS = 0V 0.1 0.2 0.8 1.6 0.4 0.6 1.0 1.2 1.4 V_{SD}, Source-to-Drain Voltage (V)



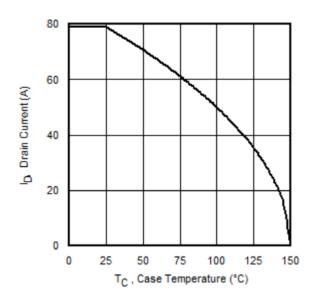


Fig 9. Maximum Drain Current vs. Case Temperature

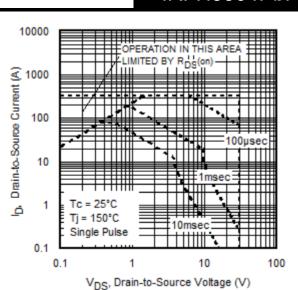


Fig 8. Maximum Safe Operating Area

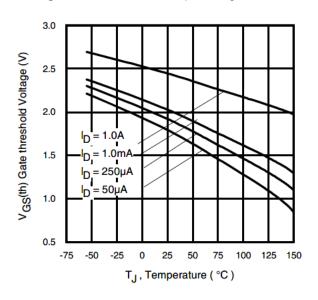


Fig 10. Drain-to-Source Breakdown Voltage

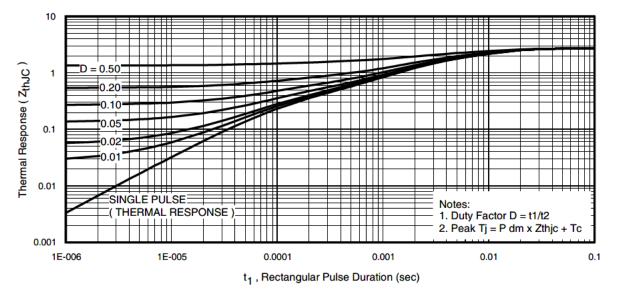


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

4

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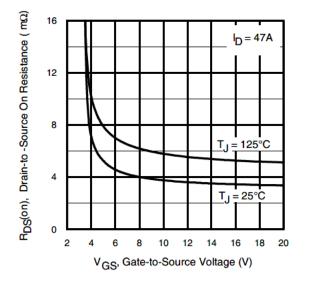


Fig 12. On-Resistance vs. Gate Voltage

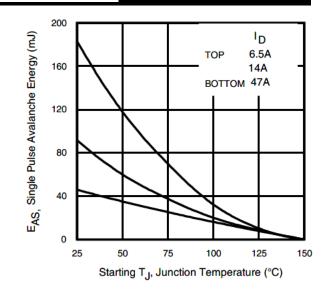


Fig 13. Maximum Avalanche Energy vs. Drain Current

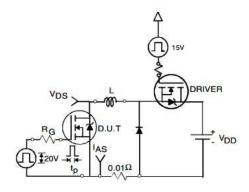


Fig 14a. Unclamped Inductive Test Circuit

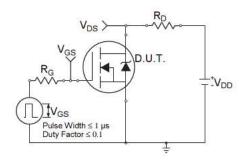


Fig 15a. Switching Time Test Circuit

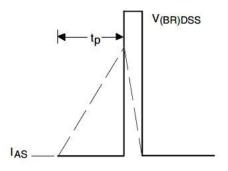


Fig 14b. Unclamped Inductive Waveforms

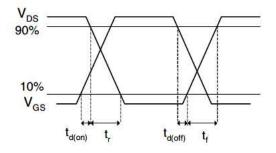


Fig 15b. Switching Time Waveforms

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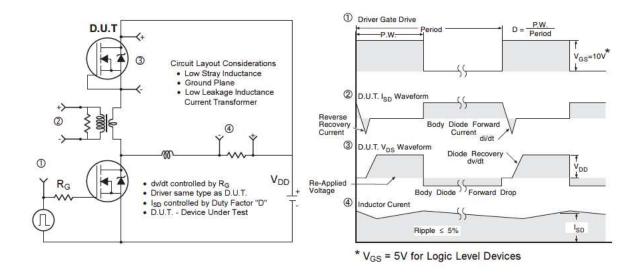


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET[®] Power MOSFETs

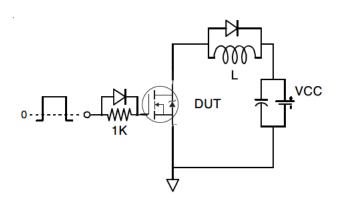


Fig 17. Gate Charge Test Circuit

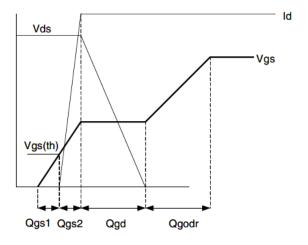
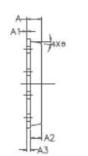


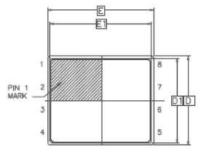
Fig 18. Gate Charge Waveform



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PQFN 5x6 Outline "B" Package Details





SIDE VIEW

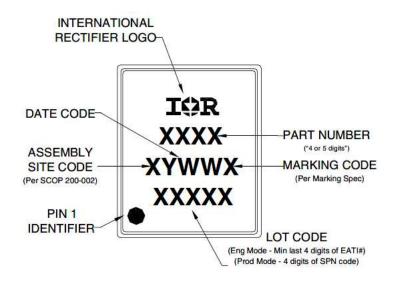
TOP VIEW

DIM	MIN	NOM	MAX	Exposed R13
A	0.800	0.830	1.05	
A1	0.000	0.020	0.050	
A2	0.580	0.630	0.680	
A3		0.254 RE	F	7 88 8 -2
0	O*	10*	12'	7 8 8 - 2
b	0.350	0.400	0.470	D2 +
D	4.850	5.000	5.150	6 3
D1	4.675	4.750	5.000	
D2	3,700	4.210	4.300	5
e		1.270 BS		
E	5.850	6.000	6.150	
E1	5,675	5.750	6.000	R
E2	3,380	3,480	3,760	H_+
E4	2.480	2.580	2.680	- FA -
L	0.550	0.800	0.900	
R	1	0.200 RE	F	E2
R1		0.100 RE	F	
R2	0.150	0.200	0.250	BOTTOM VIEW

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <u>http://www.irf.com/technical-info/appnotes/an-1136.pdf</u>

For more information on package inspection techniques, please refer to application note AN-1154: <u>http://www.irf.com/technical-info/appnotes/an-1154.pdf</u>

PQFN 5x6 Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



IRFH5304PbF

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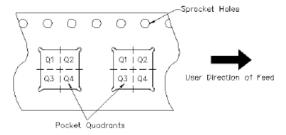
TAPE DIMENSIONS

PQFN 5x6 Tape and Reel

REEL DIMENSIONS

\oplus \oplus \oplus ф \oplus ÷ \oplus ÷ \oplus 4 Φ Φ Bo \triangleleft Reel Diameter J. - Ao ----CODE DESCRIPTION Dimension design to accommodate the component width Dimension design to accommodate the component lenght Dimension design to accommodate the component thickness Deverall width of the comfer tape Pitch between successive covity centers Ac HO Bo Ko W Reel Width (Wi)

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note : All dimension are in nominal

Package Type	Reel Diameter (Inch)	QTY	Reel Width W 1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5x6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Q1

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

	Industrial			
Qualification Level	(per JEDEC JESD47F [†] guidelines)			
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D ^{†)}		
RoHS Compliant	Yes			

† Applicable version of JEDEC standard at the time of product release.

Notes:

 $\ensuremath{\textcircled{}}$ Repetitive rating; pulse width limited by max. junction temperature.

@ Starting T_J = 25°C, L = 0.041mH, R_G = 50 $\Omega,$ I_{AS} = 47A.

3 Pulse width \leq 400 μs ; duty cycle \leq 2%.

B R_{θ} is measured at T_J of approximately 90°C.

⁽⁵⁾ When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material

© Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 9. De-rating will be required based on the actual environmental conditions.

Revision History

Date	Rev.	Comments
5/14/2014	2.1	 Updated ordering information to reflect the End-of-Life (EOL) of the mini-reel option (EOL notice #259) Update Package outline on page 7 Updated data sheet based on IR corporate template.
03/19/2015	2.2	 Updated package outline and tape and reel on pages 7 and 8
03/19/2021	2.3	 Updated datasheet based on IFX template. Updated Datasheet based on new current rating and application note :App- AN_1912_PL51_2001_180356

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Document reference ifx1

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